



# National Institute of Standards & Technology

## Certificate of Analysis

### Standard Reference Material<sup>®</sup> 3154

#### Sulfur (S) Standard Solution

Lot No. 892205

This Standard Reference Material (SRM) is intended for use as a primary calibration standard for the quantitative determination of sulfur. A unit of SRM 3154 consists of five 10 mL sealed borosilicate glass ampoules of a solution containing a known mass fraction of sulfur and a sulfuric acid volume fraction of approximately 0.1 %.

Certified Value of Sulfur: 10.30 mg/g  $\pm$  0.03 mg/g

The certified value is based on (1) gravimetric assay by barium sulfate precipitation and (2) coulometric acidimetry.

The uncertainty in the certified value is calculated as

$$U = (2u_c + B) \text{ mg/g}$$

where  $u_c$  is the combined standard uncertainty calculated according to the ISO/JCGM Guide [1] and the procedure of Schiller and Eberhardt for combining independent analytical methods [2]. The value of  $u_c$  is intended to represent, at the level of one standard deviation, the combined effect of uncertainty components associated with the gravimetric and coulometric determinations and method bias. The quantity B is an allowance for between method differences.

**Expiration of Certification:** The certification of **SRM 3154 Lot No. 892205** is valid, within the measurement uncertainty specified, until **01 July 2018**, provided the SRM is handled and stored in accordance with instructions given in this certificate (see "Instructions for Handling, Storage, and Use"). This certification is nullified if the SRM is damaged, contaminated, or otherwise modified.

**Maintenance of SRM Certification:** NIST will monitor this SRM over the period of its certification. If substantive technical changes occur that affect the certification before the expiration of certification, NIST will notify the purchaser. Registration (see attached sheet) will facilitate notification.

This SRM was prepared and gravimetrically assayed by T.A. Butler of the NIST Chemical Sciences Division. Coulometric analysis was performed by K.W. Pratt of the NIST Chemical Sciences Division.

Statistical consultation was provided by K.R. Eberhardt of the NIST Statistical Engineering Division.

Support aspects involved in the issuance of this SRM were coordinated through the NIST Office of Reference Materials.

Carlos A. Gonzalez, Chief  
Chemical Sciences Division

Robert L. Watters, Jr., Director  
Office of Reference Materials

Gaithersburg, MD 20899  
Certificate Issue Date: 02 July 2014  
*Certificate Revision History on Last Page*

## METROLOGICAL TRACEABILITY

Metrological traceability of measurement results to a given reference must be established through an unbroken chain of calibrations and/or comparisons, each having stated uncertainties [3], using measurement standards that are appropriate for the physical or chemical property being measured. Comparisons may include validation measurements using various spectroscopic or classical methods of analysis. Gravimetric or volumetric dilution is also a method of comparison, where the mass or volume of a solution before and after dilution is measured.

This SRM can be used to establish traceability of the results of sulfur measurements to NIST measurement results and standards. One approach is to calibrate analytical instruments or procedures for the determination of sulfur using standards whose values are traceable to the certified value of sulfur in this SRM. When the traceable values of such standards are assigned using this SRM for calibration, the uncertainties assigned to those values must include the uncertainty of the certified value of this SRM, appropriately combined with the uncertainties of all calibration measurements.

## INSTRUCTIONS FOR HANDLING, STORAGE, AND USE

**CAUTION:** This SRM is an acidic solution sealed in borosilicate glass ampoules with prescored stems. All appropriate safety precautions, including use of gloves during handling, should be taken. Unopened ampoules should be stored upright under normal laboratory conditions inside the original container supplied by NIST.

**Opening an Ampoule:** When an ampoule is to be opened, that area of the stem where the prescored band is located ( $\approx 5$  mm below the encircling metallic band) should be carefully wiped with a clean, damp cloth and the body of the ampoule wrapped in absorbent material. Holding the ampoule steady and with thumb and forefinger grasping the stem at the metallic band, **minimal** thumb pressure should be applied to the stem to snap it. Correctly done, the stem should break easily where prescored. Use of a metal file to break the stem is **NOT** recommended.

**Working Standard Solutions:** After opening the ampoule, the entire contents should be transferred immediately to another container and *working standard solutions* should be prepared. Working standard solutions in the range of 10 mg/kg to 100 mg/kg are recommended, from which more dilute standards can be prepared. The user should establish internal laboratory procedures that specify a maximum shelf life for a working standard solution. Two procedures for the preparation of working standard solutions follow.

**Preparation of Working Standard Solutions by Mass:** Each working standard solution should be prepared by emptying one or more ampoules of the SRM into an empty, dry, preweighed, polyethylene bottle and then reweighing the bottle. An appropriate dilute acid must be added by mass to bring the solution to the desired dilution. The dilution need not be exact since the mass of the empty bottle, mass of the bottle plus SRM aliquot, and the final diluted mass of the solution will permit calculation of the exact mass fraction (mass of sulfur per mass of solution) of the working standard solution. Dilutions prepared gravimetrically as described will need no correction for temperature and no further correction for true mass fraction in vacuum.

**Preparation of Working Standard Solutions by Volume:** Volumetric dilutions are **NOT** recommended due to uncertainties in volume calibrations and variations in density. However, for user convenience, a procedure for volumetric preparation that will minimize the major sources of error is given. Each working standard solution should be prepared by emptying one or more ampoules of the SRM into an empty, dry, polyethylene bottle and weighing the bottle. The solution must be transferred to a Class A volumetric flask and the polyethylene bottle reweighed to determine the exact mass of SRM solution transferred. The solution in the flask is diluted to 99 % + volume using an appropriate dilute acid, mixed thoroughly, and the remaining few drops needed to dilute to exact volume carefully added. The concentration (in milligrams per milliliter) of the resulting working standard solution can be calculated by multiplying the mass (in grams) of the SRM solution amount by the SRM certified value (in milligrams per gram) and dividing the numerical product by the calibrated volume (in milliliter) of the flask used for dilution. If this procedure is followed, no correction for density is needed. Although the concentration of the resulting working standard solution may be an uneven fraction of the original SRM concentration, it will be known as accurately as a volumetric dilution permits.

**Possible Presence of Other Elements:** Studies conducted by NIST have shown that components of borosilicate glass ampoules may leach into solution. In *undiluted* solutions, Na and Si mass fractions as large as 20 mg/kg, B and La mass fractions in the range 1 mg/kg to 5 mg/kg, and Al, As, Ca, Ce, Mg, Mn, Rb and Zn mass fractions in the range 0.05 mg/kg to 1 mg/kg have been found. When diluted to prepare working standard solutions, the levels of these elements become negligible for most purposes. Nevertheless, possible effects should be considered when this SRM is used.

## REFERENCES

- [1] JCGM 100:2008; *Guide to the Expression of Uncertainty in Measurement*; (GUM 1995 with Minor Corrections), Joint Committee for Guides in Metrology (JCGM) (2008); available at [http://www.bipm.org/utils/common/documents/jcgm/JCGM\\_100\\_2008\\_E.pdf](http://www.bipm.org/utils/common/documents/jcgm/JCGM_100_2008_E.pdf) (accessed July 2014); see also Taylor, B.N.; Kuyatt, C.E.; *Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results*; NIST Technical Note 1297; U.S. Government Printing Office: Washington, DC (1994); available at <http://physics.nist.gov/Pubs/contents.html> (accessed July 2014).
- [2] Schiller, S.B.; Eberhardt, K.R.; *Combining Data from Independent Chemical Analysis Methods*; Spectrochim. Acta., Vol. 46B; pp. 1607–1613 (1991).
- [3] JCGM 200.2012; *International Vocabulary of Metrology - Basic and General Concepts and Associated Terms*, 3<sup>rd</sup> ed. (2008 version with minor corrections); (JCGM) (2012); available at [http://www.bipm.org/utils/common/documents/jcgm/JCGM\\_200\\_2012.pdf](http://www.bipm.org/utils/common/documents/jcgm/JCGM_200_2012.pdf) (accessed July 2014).

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| <p><b>Certificate Revision History:</b> <b>02 July 2014</b> (Extension of certification period; corrected certificate revision history; editorial changes); <b>04 November 2011</b> (Editorial changes); <b>19 May 2010</b> (Certification period extension; editorial changes); <b>20 July 2006</b> (Certification period extension; editorial changes); <b>27 October 2003</b> (This revision reflects an extension in the certification period); <b>07 December 2001</b> (This revision reflects an extension in the certification period); <b>18 March 1999</b> (This revision reports a correction to the lot number in the “Expiration of Certification” paragraph and editorial changes); <b>18 August 1998</b> (Original certificate date).</p> |
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*Users of this SRM should ensure that the Certificate of Analysis in their possession is current. This can be accomplished by contacting the SRM Program: telephone (301) 975-2200; fax (301) 948-3730; e-mail [srminfo@nist.gov](mailto:srminfo@nist.gov); or via the Internet at <http://www.nist.gov/srm>.*